

# SKM 300GB125D



SEMITRANS™ 3

## Ultra Fast IGBT Module

SKM 300GB125D

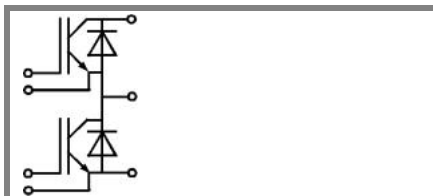
Preliminary Data

### Features

- N channel, homogeneous Silicon structure (NPT - Non punch-through IGBT)
- Low inductance case
- Short tail current with low temperature dependence
- High short circuit capability, self limiting
- Fast & soft inverse CAL diodes
- Isolated copper baseplate using DCB Direct Copper Bonding Technology
- Large clearance (10 mm) and creepage distances (20 mm)

### Typical Applications

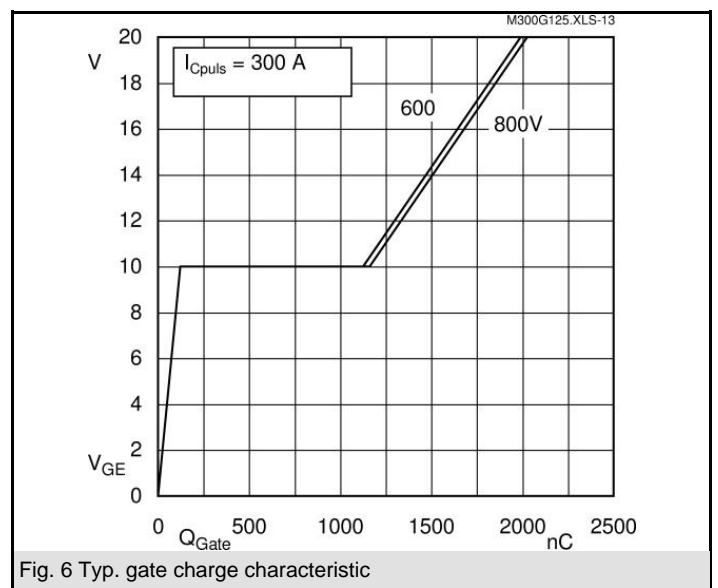
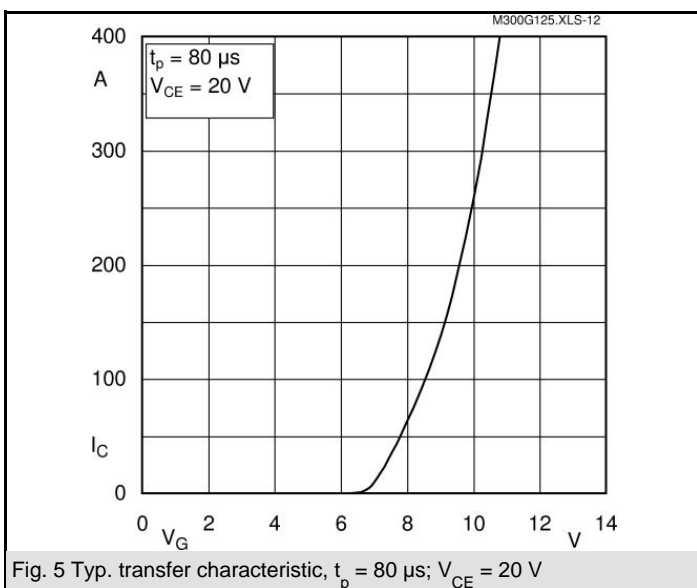
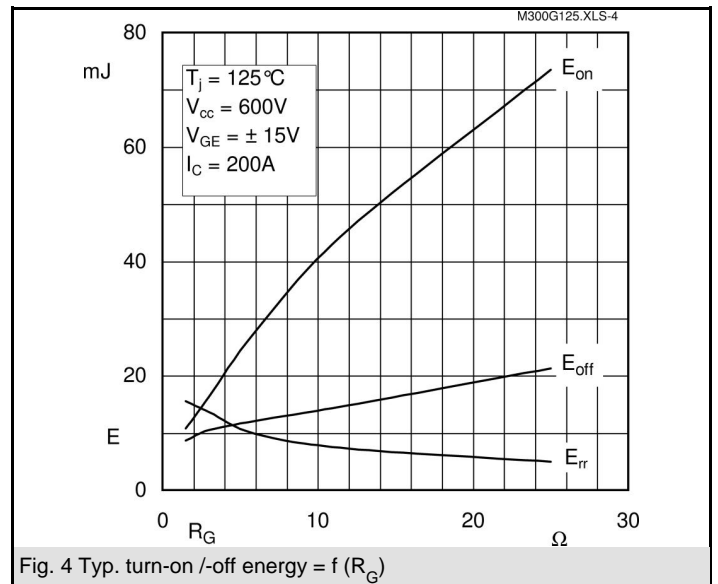
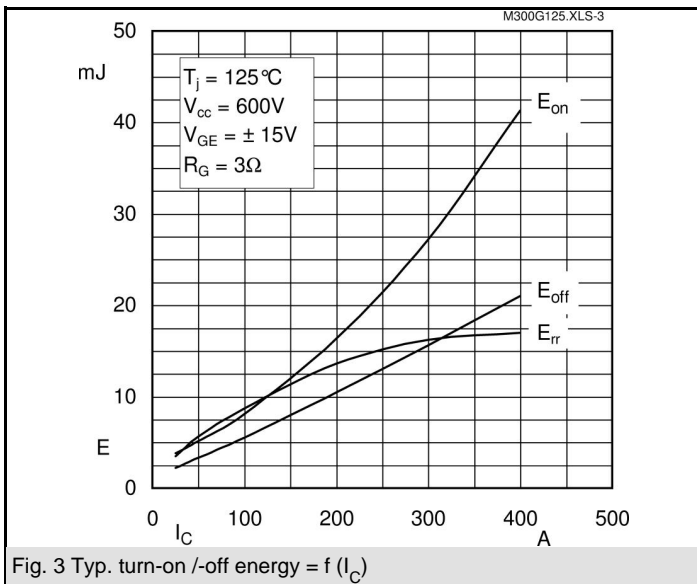
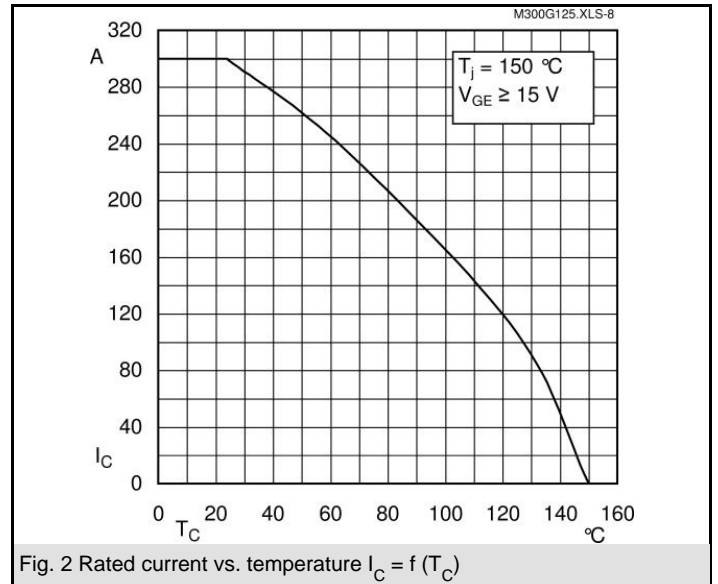
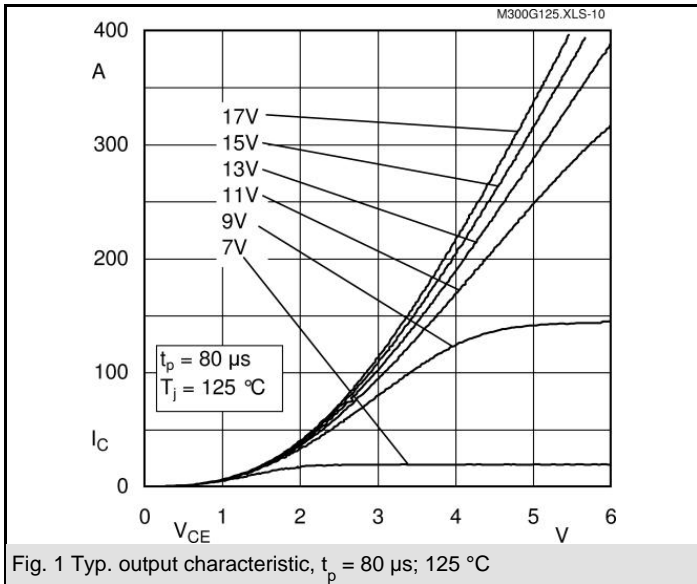
- Switched mode power supplies at  $f_{sw} > 20$  kHz
- Resonant inverters up to 100 kHz
- Silent AC motor speed control (elevators)
- Inductive heating
- Silent UPS Uninterruptable power supplies at  $f_{sw} > 20$  kHz
- Electronic (also portable) welders at  $f_{sw} > 20$  kHz

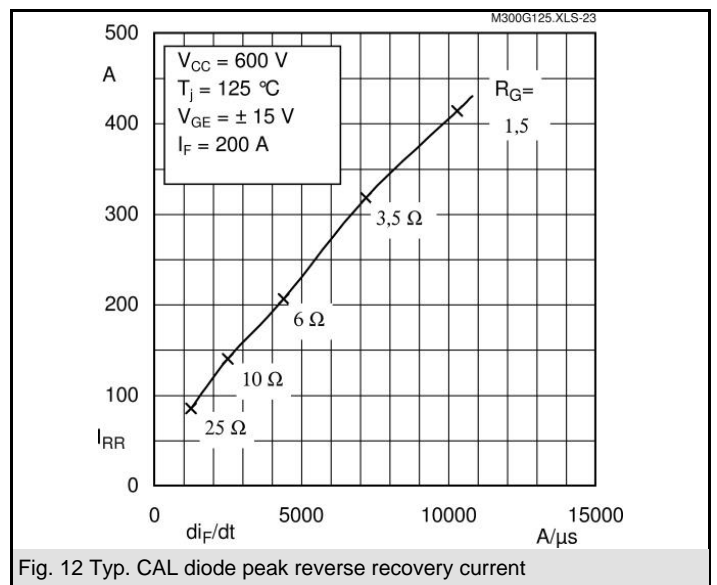
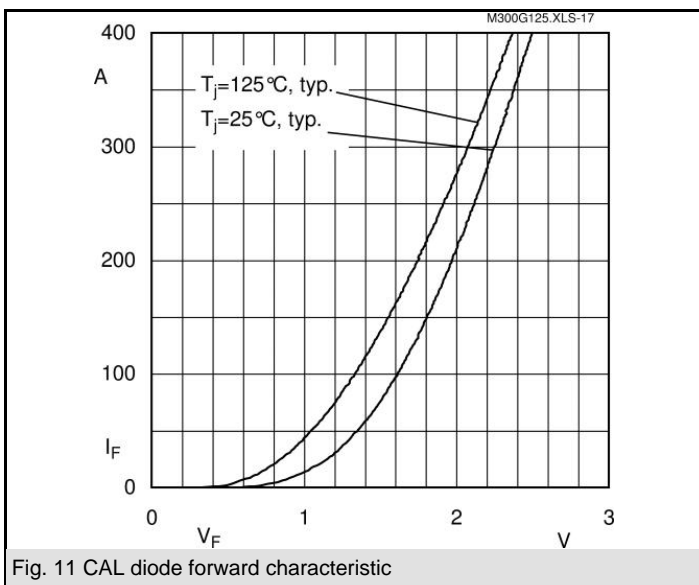
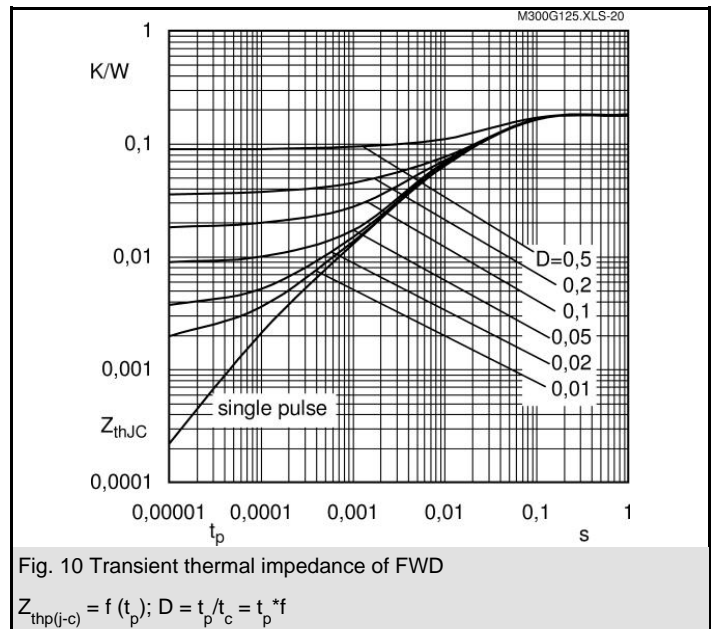
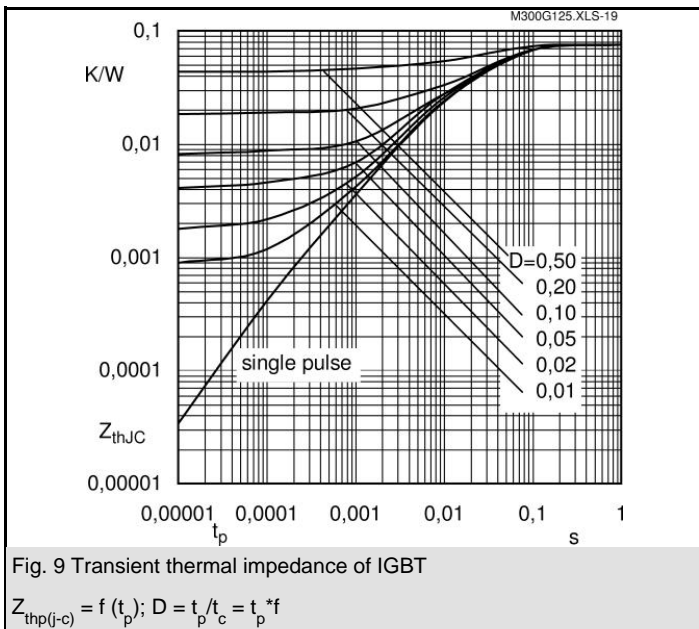
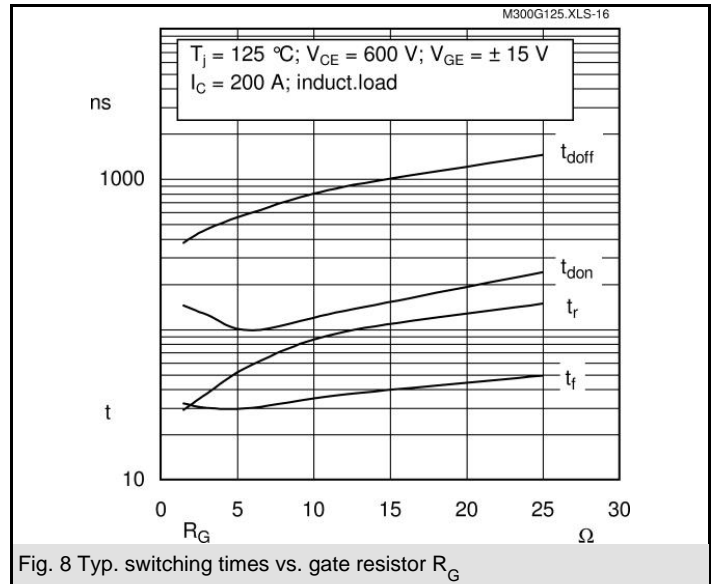
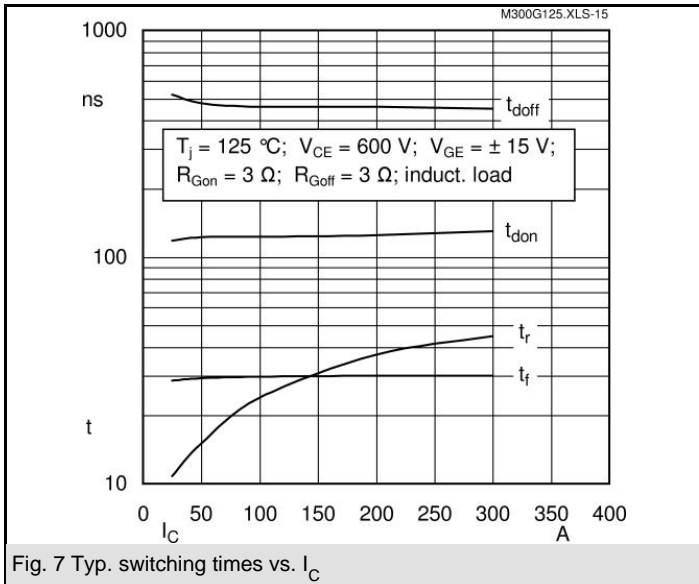


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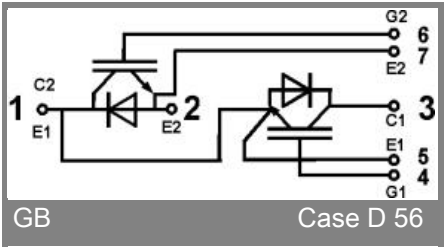
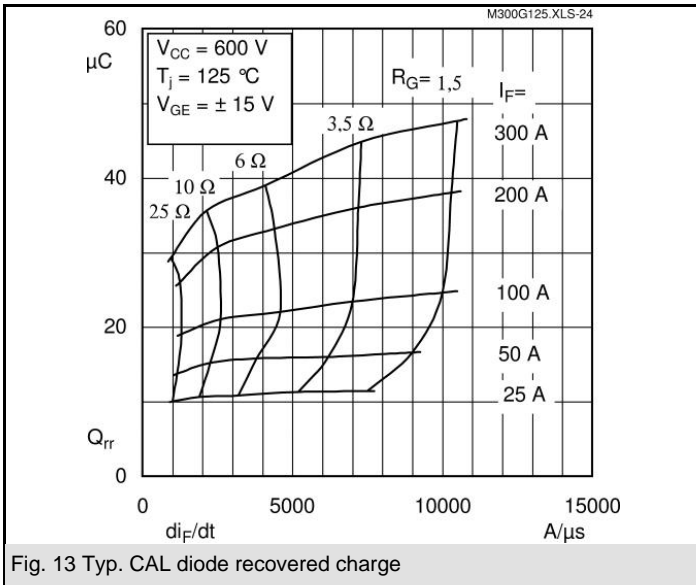
Absolute Maximum Ratings		$T_c = 25\text{ }^\circ\text{C}$ , unless otherwise specified	
Symbol	Conditions	Values	Units
<b>IGBT</b>			
$V_{CES}$		1200	V
$I_C$	$T_c = 25$ (80) $^\circ\text{C}$	300 (210)	A
$I_{CRM}$	$t_p = 1$ ms	400	A
$V_{GES}$		$\pm 20$	V
$T_{vj}$ ( $T_{stg}$ )	$T_{OPERATION} \leq T_{stg}$	- 40 ... + 150 (125)	$^\circ\text{C}$
$V_{isol}$	AC, 1 min.	4000	V
<b>Inverse diode</b>			
$I_F$	$T_c = 25$ (80) $^\circ\text{C}$	260 (180)	A
$I_{FRM}$	$t_p = 1$ ms	400	A
$I_{FSM}$	$t_p = 10$ ms; sin.; $T_j = 150\text{ }^\circ\text{C}$	2200	A

Characteristics		$T_c = 25\text{ }^\circ\text{C}$ , unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
<b>IGBT</b>					
$V_{GE(th)}$	$V_{GE} = V_{CE}$ , $I_C = 8$ mA	4,5	5,5	6,5	V
$I_{CES}$	$V_{GE} = 0$ , $V_{CE} = V_{CES}$ , $T_j = 25$ (125) $^\circ\text{C}$		0,1	0,3	mA
$V_{CE(TO)}$	$T_j = 25$ (125) $^\circ\text{C}$		1,5 (1,7)	1,75	V
$r_{CE}$	$V_{GE} = 15$ V, $T_j = 25$ (125) $^\circ\text{C}$		9 (11,5)	10,5	m $\Omega$
$V_{CE(sat)}$	$I_{Cnom} = 200$ A, $V_{GE} = 15$ V, chip level		3,3 (4)	3,85	V
$C_{ies}$	under following conditions		18	24	nF
$C_{oes}$	$V_{GE} = 0$ , $V_{CE} = 25$ V, $f = 1$ MHz		2,5	3,2	nF
$C_{res}$			1	1,3	nF
$L_{CE}$				20	nH
$R_{CC'+EE'}$	res., terminal-chip $T_c = 25$ (125) $^\circ\text{C}$		0,35 (0,5)		m $\Omega$
$t_{d(on)}$	$V_{CC} = 600$ V, $I_{Cnom} = 200$ A		130		ns
$t_r$	$R_{Gon} = R_{Goff} = 3\text{ }\Omega$ , $T_j = 125\text{ }^\circ\text{C}$		40		ns
$t_{d(off)}$	$V_{GE} = \pm 15$ V		460		ns
$t_f$			30		ns
$E_{on} (E_{off})$			16 (11)		mJ
<b>Inverse diode</b>					
$V_F = V_{EC}$	$I_{Fnom} = 200$ A; $V_{GE} = 0$ V; $T_j = 25$ (125) $^\circ\text{C}$		2 (1,8)	2,5	V
$V_{(TO)}$	$T_j = 125$ ( ) $^\circ\text{C}$		1,1	1,2	V
$r_T$	$T_j = 125$ ( ) $^\circ\text{C}$		3	5,5	m $\Omega$
$I_{RRM}$	$I_{Fnom} = 200$ A; $T_j = 125$ ( ) $^\circ\text{C}$		340		A
$Q_{rr}$	$di/dt = 8000$ A/ $\mu$ s		46		$\mu$ C
$E_{rr}$	$V_{GE} = 0$ V		13,6		mJ
<b>Thermal characteristics</b>					
$R_{th(j-c)}$	per IGBT			0,075	K/W
$R_{th(j-c)D}$	per Inverse Diode			0,18	K/W
$R_{th(c-s)}$	per module			0,038	K/W
<b>Mechanical data</b>					
$M_s$	to heatsink M6	3		5	Nm
$M_t$	to terminals M6	2,5		5	Nm
w				325	g





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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.